## INTEGRATED CIRCUITS

## DATA SHEET

## 74ALVCH162601 <br> 18－bit universal bus transceiver with $30 \Omega$ termination resistor；3－state

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

## 74ALVCH162601

## FEATURES

- Complies with JEDEC standard no. 8-1A
- CMOS low power consumption
- Direct interface with TTL levels
- MULTIBYTETM flow-through standard pin-out architecture
- Low inductance multiple $\mathrm{V}_{\mathrm{CC}}$ and ground pins for minimum noise and ground bounce
- All data inputs have bus hold circuitry
- Integrated $30 \Omega$ termination resistors.


## DESCRIPTION

The 74ALVCH162601 is an 18-bit universal transceiver featuring non-inverting 3 -state bus compatible outputs in both send and receive directions. Data flow in each direction is controlled by output enable $\left(\overline{\mathrm{OE}}_{\mathrm{AB}}\right.$ and $\left.\overline{\mathrm{OE}}_{\mathrm{BA}}\right)$, and clock $\left(\mathrm{CP}_{\mathrm{AB}}\right.$ and $\left.\mathrm{CP}_{\mathrm{BA}}\right)$ inputs. For A-to-B data flow, the device operates in the transparent mode when $L E_{A B}$ is HIGH . When $L E_{A B}$ is LOW, the A data is latched if $\mathrm{CP}_{A B}$ is held at a HIGH or LOW logic level. If $L E_{A B}$ is $L O W$, the $A$-bus data is stored in the latch/flip-flop on the LOW-to-HIGH transition of $\mathrm{CP}_{\mathrm{AB}}$. When $\overline{\mathrm{OE}}_{\mathrm{AB}}$ is LOW, the outputs are active. When $\overline{\mathrm{OE}}_{\mathrm{AB}}$ is HIGH , the outputs are in the high-impedance state. The clocks can be controlled with the clock-enable inputs ( $\overline{\mathrm{CE}}_{\mathrm{BA}} / \overline{\mathrm{CE}}_{\mathrm{AB}}$ ).

Data flow for B-to-A is similar to that of A-to-B but uses $\overline{O E}_{B A}, L E E B A^{B A}$ and $P_{B A}$.
To ensure the high-impedance state during power-down, $\overline{\mathrm{OE}}_{\mathrm{BA}}$ and $\overline{\mathrm{OE}}_{\mathrm{AB}}$ should be tied to $\mathrm{V}_{\mathrm{CC}}$ through a pull-up resistor, the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

The 74ALVCH162601 is designed with $30 \Omega$ series resistors in both HIGH or LOW output stage.

Active bus hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

## QUICK REFERENCE DATA

Ground $=0 ; \mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C} ; \mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=2.5 \mathrm{~ns}$.

| SYMBOL | PARAMETER | CONDITIONS | TYPICAL | UNIT |
| :--- | :--- | :--- | :--- | :--- |
| $\mathrm{t}_{\text {PHL }} / \mathrm{t}_{\text {PLH }}$ | propagation delay $\mathrm{A}_{\mathrm{n}}, \mathrm{B}_{\mathrm{n}}$ to $\mathrm{B}_{\mathrm{n}}, \mathrm{A}_{\mathrm{n}}$ | $\mathrm{C}_{\mathrm{L}}=30 \mathrm{pF} ; \mathrm{V}_{\mathrm{CC}}=2.5 \mathrm{~V}$ | 4.0 | ns |
|  |  | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} ; \mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ | 3.1 | ns |
| $\mathrm{C}_{\mathrm{I} / \mathrm{O}}$ | input/output capacitance |  | 8.0 | pF |
| $\mathrm{C}_{\mathrm{I}}$ | input capacitance |  | 4.0 | pF |
| $\mathrm{C}_{\mathrm{PD}}$ | power dissipation capacitance per <br> latch | notes 1 and 2 <br> outputs enabled <br> outputs disabled | 21 |  |
|  |  | 3 |  |  |

## Notes

1. $C_{P D}$ is used to determine the dynamic power dissipation ( $P_{D}$ in $\left.\mu W\right)$.
$P_{D}=C_{P D} \times V_{C C}{ }^{2} \times f_{i}+\sum\left(C_{L} \times V_{C C}{ }^{2} \times f_{0}\right)$ where:
$\mathrm{f}_{\mathrm{i}}=$ input frequency in MHz ;
$\mathrm{f}_{\mathrm{o}}=$ output frequency in MHz ;
$\sum\left(C_{L} \times V_{C C}{ }^{2} \times f_{0}\right)=$ sum of outputs;
$\mathrm{C}_{\mathrm{L}}=$ output load capacitance in pF ;
$\mathrm{V}_{\mathrm{CC}}=$ supply voltage in Volts.
2. The condition is $\mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ to $\mathrm{V}_{\mathrm{CC}}$.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

## FUNCTION TABLE

See note 1.

| INPUTS |  |  |  |  | OUTPUTS | STATUS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\overline{C E}_{\text {XX }}$ | $\overline{O E}_{x x}$ | LE ${ }_{\text {Xx }}$ | $\mathrm{CP}_{\mathrm{xx}}$ | $A_{n}, B_{n}$ |  |  |
| X | H | X | X | X | Z | disabled |
| $\begin{aligned} & \hline X \\ & X \end{aligned}$ | $\begin{aligned} & \hline \mathrm{L} \\ & \mathrm{~L} \end{aligned}$ | $\begin{aligned} & \hline \mathrm{H} \\ & \mathrm{H} \end{aligned}$ | $\begin{aligned} & \hline X \\ & X \end{aligned}$ | $\begin{aligned} & \mathrm{H} \\ & \mathrm{~L} \end{aligned}$ | $\begin{aligned} & \hline \mathrm{H} \\ & \mathrm{~L} \end{aligned}$ | transparent |
| H | L | L | X | X | NC | hold |
| $\begin{aligned} & \hline \mathrm{L} \\ & \mathrm{~L} \end{aligned}$ | $\begin{aligned} & \bar{L} \\ & L \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{~L} \end{aligned}$ | $\begin{aligned} & \uparrow \\ & \uparrow \end{aligned}$ | $\begin{aligned} & \mathrm{h} \\ & \mathrm{l} \end{aligned}$ | $\begin{aligned} & \hline \mathrm{H} \\ & \mathrm{~L} \end{aligned}$ | clock and display |
| $\begin{aligned} & \mathrm{L} \\ & \mathrm{~L} \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{~L} \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{~L} \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | $\begin{aligned} & \hline X \\ & X \end{aligned}$ | NC | hold |

## Note

1. $X X=A B$ for $A$-to- $B$ direction, $B A$ for $B$-to-A direction;
$H=$ HIGH voltage level;
L = LOW voltage level;
$h=$ HIGH state must be present one set-up time before the LOW-to-HIGH transition of $\mathrm{CP}_{\mathrm{xx}}$;
$\mathrm{I}=\mathrm{LOW}$ state must be present one set-up time before the LOW-to-HIGH transition of $\mathrm{CP}_{\mathrm{XX}}$;
X = don't care;
$\uparrow=$ LOW-to-HIGH level transition;
NC = no change;
$Z$ = high-impedance OFF-state.

ORDERING INFORMATION

| TYPE NUMBER | PACKAGE |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | TEMPERATURE RANGE | PINS | PACKAGE | MATERIAL | CODE |
| 74ALVCH162601DGG | -40 to $+85^{\circ} \mathrm{C}$ | 56 | TSSOP | plastic | SOT364-1 |

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

PINNING

| PIN | SYMBOL | DESCRIPTION |
| :--- | :--- | :--- |
| 1 | $\mathrm{OE}_{\mathrm{AB}}$ | output enable A-to-B |
| 2 | $\mathrm{LE}_{\mathrm{AB}}$ | latch enable A-to-B |
| $3,5,6,8,9,10,12,13,14,15$, <br> $16,17,19,20,21,23,24,26$ | $\mathrm{~A}_{0}$ to $\mathrm{A}_{17}$ | data inputs/outputs |
| $4,11,18,25,32,39,46,53$ | GND | ground (0 V) |
| $7,22,35,50$ | $\mathrm{~V}_{\mathrm{CC}}$ | DC supply voltage |
| 27 | $\mathrm{OE}_{\mathrm{BA}}$ | output enable B-to-A |
| 28 | $\mathrm{LE}_{\mathrm{BA}}$ | latch enable B-to-A |
| 29 | $\mathrm{CE}_{\mathrm{BA}}$ | clock enable B-to-A |
| 30 | $\mathrm{CP}_{\mathrm{BA}}$ | clock input B-to-A |
| $31,33,34,36,37,38,40,41$, $\mathrm{B}_{17}$ to $\mathrm{B}_{0}$ <br> $42,43,44,45,47,48,49,51$,  <br> 52,54 data inputs/outputs <br> 55 $\mathrm{CP}_{\mathrm{AB}}$ |  |  |
| 56 | $\mathrm{CE}_{\mathrm{AB}}$ | clock input A-to-B |

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

| $\overline{\mathrm{O}}_{\mathrm{AB}} \square$ | $\bigcirc$ | $56 \overline{C E}_{A B}$ |
| :---: | :---: | :---: |
| $L_{\text {LE }}{ }_{\text {AB }}{ }^{2}$ |  | $55 \mathrm{CP}_{\mathrm{AB}}$ |
| $\mathrm{A}_{0}{ }^{3}$ |  | 54 B 0 |
| GND 4 |  | 53 GND |
| $\mathrm{A}_{1} 5$ |  | $52 \mathrm{~B}_{1}$ |
| $\mathrm{A}_{2} 6$ |  | $51 \mathrm{~B}_{2}$ |
| $\mathrm{v}_{\mathrm{CC}} 7$ |  | 50 VCC |
| $\mathrm{A}_{3} 8$ |  | $49 \mathrm{~B}_{3}$ |
| $\mathrm{A}_{4} 9$ |  | ${ }_{48} \mathrm{~B}_{4}$ |
| $\mathrm{A}_{5} 10$ |  | 47 B 5 |
| GND 11 |  | 46 GND |
| $A_{6} 12$ |  | $45 \mathrm{~B}_{6}$ |
| $\mathrm{A}_{7} 13$ |  | $44 \mathrm{~B}_{7}$ |
| $\mathrm{A}_{8} 14$ |  | 43 B 8 |
| Ag 15 | 162601 | 42 B 9 |
| $\mathrm{A}_{10} 16$ |  | $4{ }_{41} B_{10}$ |
| $\mathrm{A}_{11} 17$ |  | $40 \mathrm{~B}_{11}$ |
| GND 18 |  | 39 GND |
| $\mathrm{A}_{12} \quad 19$ |  | $38 \mathrm{~B}_{12}$ |
| $\mathrm{A}_{13} 20$ |  | $37 \mathrm{~B}_{13}$ |
| $\mathrm{A}_{14} 21$ |  | $36 B_{14}$ |
| $\mathrm{v}_{\mathrm{CC}} 22$ |  | 35 V CC |
| $\mathrm{A}_{15} \quad 23$ |  | ${ }_{34} \mathrm{~B}_{15}$ |
| $\mathrm{A}_{16} 24$ |  | $33 \mathrm{~B}_{16}$ |
| GND 25 |  | 32 GND |
| $\mathrm{A}_{17} \quad 26$ |  | $31 \mathrm{~B}_{17}$ |
| $\overline{O E}_{B A} \quad 27$ |  | $30 \mathrm{CP}_{\text {BA }}$ |
| $L_{\text {LEA }} 28$ |  | $29 \overline{C E}_{B A}$ |

Fig. 2 Bus hold circuit.

Fig. 1 Pin configuration.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state



Fig. 3 Logic diagram (one section).


Fig. 4 IEC logic symbol.
Fig. 5 Logic symbol.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

## RECOMMENDED OPERATING CONDITIONS

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {CC }}$ | DC supply voltage for max. speed performance for max. speed performance for low-voltage applications | $\begin{aligned} & \mathrm{C}_{\mathrm{L}}=30 \mathrm{pF} \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} \end{aligned}$ | $\begin{array}{\|l\|} \hline 2.3 \\ 3.0 \\ 1.2 \end{array}$ | $\begin{aligned} & 2.5 \\ & 3.3 \\ & 2.4 \end{aligned}$ | $\begin{array}{\|l} 2.7 \\ 3.6 \\ 3.6 \end{array}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{~V} \end{aligned}$ |
| $\mathrm{V}_{1}$ | DC input voltage |  | 0 | - | $\mathrm{V}_{\text {CC }}$ | V |
| $\mathrm{V}_{\mathrm{O}}$ | DC output voltage |  | 0 | - | $\mathrm{V}_{\mathrm{CC}}$ | V |
| $\mathrm{T}_{\mathrm{amb}}$ | operating ambient temperature | in free air | -40 | - | +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{t}_{\mathrm{r}}, \mathrm{t}_{\mathrm{f}}$ | input rise and fall times | $\mathrm{V}_{\mathrm{CC}}=2.3$ to 3.0 V | 0 | - | 20 | ns/V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.0$ to 3.6 V | 0 | - | 10 | ns/V |

## LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134); voltages are referenced to GND (ground = 0 V ).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
| :--- | :--- | :--- | :--- | :--- | :--- |
| $\mathrm{V}_{\mathrm{CC}}$ | DC supply voltage |  | -0.5 | +4.6 | V |
| $\mathrm{I}_{\mathrm{IK}}$ | DC input diode current | $\mathrm{V}_{\mathrm{I}}<0$ | - | -50 | mA |
| $\mathrm{~V}_{\mathrm{I}}$ | DC input voltage | note 1 | -0.5 | +4.6 | V |
| $\mathrm{I}_{\mathrm{OK}}$ | DC output diode current | $\mathrm{V}_{\mathrm{O}}>\mathrm{V}_{\mathrm{CC}}$ or $\mathrm{V}_{\mathrm{O}}<0$ | - | $\pm 50$ | mA |
| $\mathrm{~V}_{\mathrm{O}}$ | DC output voltage | note 1 | -0.5 | $\mathrm{~V}_{\mathrm{CC}}+0.5$ | V |
| $\mathrm{I}_{\mathrm{O}}$ | DC output source or sink current | $\mathrm{V}_{\mathrm{O}}=0$ to $\mathrm{V}_{\mathrm{CC}}$ | - | $\pm 50$ | mA |
| $\mathrm{I}_{\mathrm{CC}}, \mathrm{I}_{\mathrm{GND}}$ | DC $\mathrm{V}_{\text {CC }}$ or GND current |  | - | $\pm 100$ | mA |
| $\mathrm{~T}_{\text {stg }}$ | storage temperature |  | -65 | +150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{P}_{\text {tot }}$ | power dissipation | for temperature range: -40 to $+125^{\circ} \mathrm{C} ;$ <br> note 2 | - | 600 | mW |

## Notes

1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. Above $55^{\circ} \mathrm{C}$ the value of $\mathrm{P}_{\text {tot }}$ derates linearly with $8 \mathrm{~mW} / \mathrm{K}$.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

## DC CHARACTERISTICS

Over recommended operating conditions; voltages are referenced to GND (ground = 0 V ).

| SYMBOL | PARAMETER | TEST CONDITIONS |  |  | $\mathrm{T}_{\text {amb }}=-40 \mathrm{TO}+85{ }^{\circ} \mathrm{C}$ |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | V ${ }_{\text {(V) }}$ | OTHER | $\mathrm{V}_{\mathrm{cc}}(\mathrm{V})$ | MIN. | TYP. ${ }^{(1)}$ | MAX. |  |
| $\mathrm{V}_{\mathrm{IH}}$ | HIGH-level input voltage |  |  | 2.3 to 2.7 | 1.7 | 1.2 | - | V |
|  |  |  |  | 2.7 to 3.6 | 2.0 | 1.5 | - |  |
| $\mathrm{V}_{\text {IL }}$ | LOW-level input voltage |  |  | 2.3 to 2.7 | - | 1.2 | 0.7 | V |
|  |  |  |  | 2.7 to 3.6 | - | 1.5 | 0.8 |  |
| $\mathrm{V}_{\mathrm{OH}}$ | HIGH-level output voltage | $\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\text {IL }}$ | $\mathrm{I}_{0}=-100 \mu \mathrm{~A}$ | 2.3 to 3.6 | $\mathrm{V}_{\mathrm{CC}}-0.2$ | $\mathrm{V}_{C C}$ | - | V |
|  |  |  | $\mathrm{I}_{\mathrm{O}}=-4 \mathrm{~mA}$ | 2.3 | $\mathrm{V}_{\mathrm{CC}}-0.4$ | $V_{C C}-0.11$ | - |  |
|  |  |  | $\mathrm{l}_{\mathrm{O}}=-6 \mathrm{~mA}$ | 2.3 | $\mathrm{V}_{C C}-0.6$ | $\mathrm{V}_{C C}-0.17$ | - |  |
|  |  |  | $\mathrm{I}_{\mathrm{O}}=-4 \mathrm{~mA}$ | 2.7 | $\mathrm{V}_{\mathrm{CC}}-0.5$ | $\mathrm{V}_{C C}-0.09$ | - |  |
|  |  |  | $\mathrm{l}_{\mathrm{O}}=-8 \mathrm{~mA}$ | 2.7 | $V_{C C}-0.7$ | $\mathrm{V}_{C C}-0.19$ | - |  |
|  |  |  | $\mathrm{l}_{\mathrm{O}}=-6 \mathrm{~mA}$ | 3.0 | $\mathrm{V}_{C C}-0.6$ | $\mathrm{V}_{C C}-0.13$ | - |  |
|  |  |  | $\mathrm{I}_{\mathrm{O}}=-12 \mathrm{~mA}$ | 3.0 | $\mathrm{V}_{\mathrm{CC}}-1.0$ | $\mathrm{V}_{\text {CC }}-0.27$ | - |  |
| $\mathrm{V}_{\mathrm{OL}}$ | LOW-level output voltage | $\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\text {IL }}$ | $\mathrm{I}_{\mathrm{O}}=100 \mu \mathrm{~A}$ | 2.3 to 3.6 | - | GND | 0.20 | V |
|  |  |  | $\mathrm{l}_{0}=4 \mathrm{~mA}$ | 2.3 | - | 0.07 | 0.40 |  |
|  |  |  | $\mathrm{I}_{0}=6 \mathrm{~mA}$ | 2.3 | - | 0.11 | 0.55 |  |
|  |  |  | $\mathrm{l}_{0}=4 \mathrm{~mA}$ | 2.7 | - | 0.06 | 0.40 |  |
|  |  |  | $\mathrm{l}_{0}=8 \mathrm{~mA}$ | 2.7 | - | 0.13 | 0.60 |  |
|  |  |  | $\mathrm{I}_{0}=6 \mathrm{~mA}$ | 3.0 | - | 0.09 | 0.55 |  |
|  |  |  | $\mathrm{l}_{\mathrm{O}}=12 \mathrm{~mA}$ | 3.0 | - | 0.19 | 0.80 |  |
| I | input leakage current | $\begin{aligned} & \mathrm{V}_{\mathrm{Cc}} \text { or } \\ & \text { GND } \end{aligned}$ |  | 2.3 to 3.6 | - | 0.1 | 5 | $\mu \mathrm{A}$ |
| $\mathrm{l}_{\mathrm{Oz}}$ | 3-state output OFF-state current | $\mathrm{V}_{\mathrm{IH}}$ or $\mathrm{V}_{\text {IL }}$ | $\mathrm{V}_{\mathrm{O}}=\mathrm{V}_{\mathrm{CC}} \text { or }$ GND | 2.3 to 3.6 | - | 0.1 | 10 | $\mu \mathrm{A}$ |
| ICC | quiescent supply voltage | $\mathrm{V}_{\mathrm{CC}}$ or GND | $\mathrm{l}_{0}=0$ | 2.3 to 3.6 | - | 0.2 | 40 | $\mu \mathrm{A}$ |
| $\Delta \mathrm{I}_{\mathrm{CC}}$ | additional quiescent supply current given per data I/O pin with bus hold | $\mathrm{V}_{C C}-0.6$ | $\mathrm{I}_{0}=0$ | 2.3 to 3.6 | - | 150 | 750 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{BHL}}$ | bus hold LOW sustaining current | $0.7{ }^{(2)}$ |  | $2.3{ }^{(2)}$ | 45 | - | - | $\mu \mathrm{A}$ |
|  |  | $0.8^{(2)}$ |  | $3.0^{(2)}$ | 75 | 150 | - |  |
| $\mathrm{I}_{\text {BHH }}$ | bus hold HIGH sustaining current | $1.7{ }^{(2)}$ |  | $2.3{ }^{(2)}$ | -45 |  | - | $\mu \mathrm{A}$ |
|  |  | $2.0{ }^{(2)}$ |  | $3.0^{(2)}$ | -75 | -175 | - |  |
| $\mathrm{I}_{\text {BHLO }}$ | bus hold LOW overdrive current |  |  | $3.6{ }^{(2)}$ | 500 | - | - | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {BHHO }}$ | bus hold LOW overdrive current |  |  | $3.6{ }^{(2)}$ | -500 | - | - | $\mu \mathrm{A}$ |

## Notes

1. All typical values are measured at $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
2. Valid for data inputs of bus hold parts.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

## AC CHARACTERISTICS FOR $\mathrm{V}_{\mathrm{CC}}=2.3$ TO 2.7 V

Ground $=0 \mathrm{~V} ; \mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}} \leq 2.0 \mathrm{~ns} ; \mathrm{C}_{\mathrm{L}}=30 \mathrm{pF}$.

| SYMBOL | PARAMETER | TEST CONDITIONS |  | $\mathrm{T}_{\text {amb }}=-40 \mathrm{TO}+85{ }^{\circ} \mathrm{C}$ |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | WAVEFORMS | $\mathrm{V}_{\mathrm{cc}}(\mathrm{V})$ | MIN. | TYP. ${ }^{(1)}$ | MAX. |  |
| $\mathrm{t}_{\text {PHL }} / \mathrm{t}_{\text {PLH }}$ | propagation delay $A_{n}, B_{n}$ to $B_{n}, A_{n}$ | see Figs 6 and 10 | 2.3 to 2.7 | 1.3 | 4.0 | 5.3 | ns |
|  | propagation delay $L E_{A B}, L E_{B A}$ to $B_{n}, A_{n}$ | see Figs 7 and 10 | 2.3 to 2.7 | 1.0 | 4.5 | 6.0 | ns |
|  | propagation delay $\mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}} \text { to } \mathrm{B}_{\mathrm{n}}, \mathrm{~A}_{\mathrm{n}}$ | see Figs 7 and 10 | 2.3 to 2.7 | 1.5 | 4.7 | 6.4 | ns |
| $\mathrm{t}_{\text {PZH }} / \mathrm{t}_{\text {PZL }}$ | 3-state output enable time $\overline{\mathrm{OE}}_{\mathrm{AB}}, \overline{\mathrm{OE}}_{\mathrm{BA}}$ to $\mathrm{B}_{\mathrm{n}}, \mathrm{A}_{\mathrm{n}}$ | see Figs 8 and 10 | 2.3 to 2.7 | 1.6 | 3.9 | 6.1 | ns |
| $\mathrm{t}_{\text {PHZ }} / \mathrm{t}_{\text {PLZ }}$ | 3-state output disable time $\overline{\mathrm{OE}}_{\mathrm{AB}}, \overline{\mathrm{OE}}_{\mathrm{BA}}$ to $\mathrm{B}_{\mathrm{n}}, \mathrm{A}_{\mathrm{n}}$ | see Figs 8 and 10 | 2.3 to 2.7 | 1.8 | 2.6 | 5.7 | ns |
| $\mathrm{t}_{\mathrm{w}}$ | clock pulse width HIGH LE ${ }_{\text {AB }}$ or LE BA | see Figs 7 and 10 | 2.3 to 2.7 | 3.3 | 1.6 | - | ns |
|  | clock pulse width HIGH or LOW CP ${ }_{\text {AB }}$ or CP $_{\mathrm{BA}}$ | see Figs 7 and 10 | 2.3 to 2.7 | 3.3 | 2.0 | - | ns |
| $\mathrm{t}_{\text {su }}$ | set-up time $\mathrm{A}_{\mathrm{n}}, \mathrm{~B}_{\mathrm{n}} \text { to } \mathrm{CP}_{\mathrm{AB}}, C P_{\mathrm{BA}}$ | see Figs 9 and 10 | 2.3 to 2.7 | +2.3 | -0.2 | - | ns |
|  | set-up time $A_{n}, B_{n} \text { to } L E_{A B}, L E_{B A}$ | see Figs 9 and 10 | 2.3 to 2.7 | 1.3 | 0.1 | - | ns |
|  | set-up time $\overline{\mathrm{CE}}_{\mathrm{AB}}, \overline{\mathrm{CE}}_{\mathrm{BA}}$ to $\mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$ |  | 2.3 to 2.7 | +2.0 | -0.4 | - | ns |
| $t_{n}$ | hold time $\mathrm{A}_{\mathrm{n}}, \mathrm{~B}_{\mathrm{n}} \text { to } \mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$ | see Figs 9 and 10 | 2.3 to 2.7 | 1.2 | 0.3 | - | ns |
|  | $\begin{array}{\|l} \hline \text { hold time } \\ A_{n}, B_{n} \text { to } L E_{A B}, L E_{B A} \\ \hline \end{array}$ | see Figs 9 and 10 | 2.3 to 2.7 | 1.3 | 0.2 | - | ns |
|  | hold time $\overline{\mathrm{CE}}_{\mathrm{AB}}, \overline{\mathrm{CE}}_{\mathrm{BA}}$ to $\mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$ |  | 2.3 to 2.7 | 1.1 | 0.4 | - | ns |
| $\mathrm{f}_{\text {max }}$ | maximum clock pulse frequency | see Figs 7 and 10 | 2.3 to 2.7 | 150 | 190 | - | MHz |

## Note

1. All typical values are measured at $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$ and $\mathrm{V}_{\mathrm{CC}}=2.5 \mathrm{~V}$.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

## AC CHARACTERISTICS FOR $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$ AND $\mathrm{V}_{\mathrm{CC}}=3.0$ TO 3.6 V

Ground $=0 \mathrm{~V} ; \mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}} \leq 2.5 \mathrm{~ns} ; \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$.

| SYMBOL | PARAMETER | TEST CONDITIONS |  | $\mathrm{T}_{\text {amb }}=-40 \mathrm{TO}+85{ }^{\circ} \mathrm{C}$ |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | WAVEFORMS | $\mathrm{V}_{\mathrm{Cc}}(\mathrm{V})$ | MIN. | TYP. ${ }^{(1)}$ | MAX. |  |
| $\mathrm{t}_{\text {PHL }} / \mathrm{t}_{\text {PLH }}$ | propagation delay $A_{n}, B_{n}$ to $B_{n}, A_{n}$ | see Figs 6 and 10 | 2.7 | - | 3.9 | 5.2 | ns |
|  |  |  | 3.0 to 3.6 | 1.6 | $3.1{ }^{(2)}$ | 4.5 |  |
|  | propagation delay $L_{A B}, L_{B A}$ to $B_{n}, A_{n}$ | see Figs 7 and 10 | 2.7 | - | 4.3 | 5.9 | ns |
|  |  |  | 3.0 to 3.6 | 1.5 | $3.5{ }^{(2)}$ | 5.1 |  |
|  | propagation delay $\mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$ to $\mathrm{B}_{\mathrm{n}}, \mathrm{A}_{\mathrm{n}}$ | see Figs 7 and 10 | 2.7 | - | 4.5 | 6.3 | ns |
|  |  |  | 3.0 to 3.6 | 1.6 | $3.7{ }^{(2)}$ | 5.5 |  |
| $\mathrm{t}_{\text {PZH }} / \mathrm{t}_{\text {PZL }}$ | 3-state output enable time $\overline{\mathrm{OE}}_{\mathrm{AB}}, \overline{\mathrm{OE}}_{\mathrm{BA}}$ to $\mathrm{B}_{\mathrm{n}}, \mathrm{A}_{\mathrm{n}}$ | see Figs 8 and 10 | 2.7 | - | 3.9 | 6.7 | ns |
|  |  |  | 3.0 to 3.6 | 1.6 | $3.1^{(2)}$ | 5.7 |  |
| $\mathrm{t}_{\text {PHZ }} / \mathrm{t}_{\text {PLZ }}$ | 3-state output disable time $\overline{O E}_{A B}, \overline{O E}_{B A}$ to $B_{n}, A_{n}$ | see Figs 8 and 10 | 2.7 | - | 3.2 | 5.3 | ns |
|  |  |  | 3.0 to 3.6 | 1.8 | $2.9{ }^{(2)}$ | 4.8 |  |
| $\mathrm{t}_{\mathrm{w}}$ | clock pulse width $\mathrm{LE}_{\mathrm{AB}}, \mathrm{LE}_{\mathrm{BA}}$ to $\mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$ | see Figs 7 and 10 | 2.7 | 3.3 | 0.7 | - | ns |
|  |  |  | 3.0 to 3.6 | 3.3 | $0.9^{(2)}$ | - |  |
|  | clock pulse width HIGH or LOW CP ${ }_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$ | see Figs 7 and 10 | 2.7 | 3.3 | 1.2 | - | ns |
|  |  |  | 3.0 to 3.6 | 3.3 | $0.9{ }^{(2)}$ | - |  |
| $\mathrm{t}_{\text {su }}$ | set-up time <br> $A_{n}, B_{n}$ to $\mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$ | see Figs 9 and 10 | 2.7 | 2.4 | 0.0 | - | ns |
|  |  |  | 3.0 to 3.6 | +2.1 | $-0.2^{(2)}$ | - |  |
|  | set-up time <br> $A_{n}, B_{n}$ to $L E_{A B}, L E_{B A}$ | see Figs 9 and 10 | 2.7 | +1.2 | -0.2 | - | ns |
|  |  |  | 3.0 to 3.6 | 1.1 | $0.3^{(2)}$ | - |  |
|  | $\frac{\text { set-up time }}{\overline{\mathrm{CE}}_{\mathrm{AB}}, \overline{\mathrm{CE}}_{\mathrm{BA}} \text { to } \mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}}$ |  | 2.7 | +2.0 | -0.7 | - | ns |
|  |  |  | 3.0 to 3.6 | +1.7 | $-0.2^{(2)}$ | - |  |
| $\mathrm{th}_{\mathrm{h}}$ | hold time <br> $A_{n}, B_{n}$ to $C P_{A B}, C P_{B A}$ | see Figs 9 and 10 | 2.7 | 1.1 | 0.3 | - | ns |
|  |  |  | 3.0 to 3.6 | +1.0 | $-0.1^{(2)}$ | - |  |
|  | hold time <br> $A_{n}, B_{n}$ to $L E_{A B}, L E_{B A}$ | see Figs 9 and 10 | 2.7 | 1.6 | 0.1 | - | ns |
|  |  |  | 3.0 to 3.6 | 1.4 | $0.1^{(2)}$ | - |  |
|  | hold time$\overline{\mathrm{CE}}_{\mathrm{AB}}, \mathrm{CE}_{\mathrm{BA}} \text { to } \mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$ |  | 2.7 | 1.2 | 0.6 | - | ns |
|  |  |  | 3.0 to 3.6 | 1.1 | $0.4{ }^{(2)}$ | - |  |
| $\mathrm{f}_{\text {max }}$ | maximum clock pulse frequency | see Figs 7 and 10 | 2.7 | 150 | 190 | - | MHz |
|  |  |  | 3.0 to 3.6 | 150 | 240 ${ }^{(2)}$ | - |  |

## Notes

1. All typical values are measured at $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
2. Typical values at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

AC WAVEFORMS


Fig. 6 The input $A_{n}, B_{n}$ to output $B_{n}, A_{n}$ propagation delay times.

## Notes: $\mathrm{V}_{\mathrm{CC}}=2.3$ to 2.7 V

$\mathrm{V}_{\mathrm{M}}=0.5 \mathrm{~V}_{\mathrm{CC}} ;$
$\mathrm{V}_{\mathrm{X}}=\mathrm{V}_{\mathrm{OL}}+150 \mathrm{mV}$;
$\mathrm{V}_{\mathrm{Y}}=\mathrm{V}_{\mathrm{OH}}-150 \mathrm{mV}$;
$V_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$;
$\mathrm{V}_{\mathrm{OL}}$ and $\mathrm{V}_{\mathrm{OH}}$ are typical output voltage drop that occur with the output load.
Notes: $\mathrm{V}_{\mathrm{Cc}}=3.0$ to 3.6 V and $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$
$\mathrm{V}_{\mathrm{M}}=1.5 \mathrm{~V}$;
$\mathrm{V}_{\mathrm{X}}=\mathrm{V}_{\mathrm{OL}}+300 \mathrm{mV}$;
$V_{Y}=V_{\mathrm{OH}}-300 \mathrm{mV}$;
$\mathrm{V}_{\mathrm{I}}=2.7 \mathrm{~V}$;
$\mathrm{V}_{\mathrm{OL}}$ and $\mathrm{V}_{\mathrm{OH}}$ are typical output voltage drop that occur with the output load.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state



Fig. 7 Latch enable input $L E_{A B}, L E_{B A}$ and clock input $\mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$ to output $\mathrm{B}_{\mathrm{n}}, \mathrm{A}_{\mathrm{n}}$ propagation delay times; pulse width and $f_{\max }$ of $\mathrm{CP}_{\mathrm{AB}}, \mathrm{CP}_{\mathrm{BA}}$.


Fig. 8 3-state enable and disable times.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state



The shaded areas indicate when the input is permitted to change for predictable output performance.
Fig. 9 Data set-up and hold times for $A_{n}$ and $B_{n}$ inputs to $\mathrm{LE}_{A B}, \mathrm{LE}_{\mathrm{BA}}, \mathrm{CP}_{\mathrm{AB}}$ or $\mathrm{CP}_{\mathrm{BA}}$ inputs.


| TEST | S1 |
| :--- | :--- |
| $\mathrm{t}_{\text {PLH }} / \mathrm{t}_{\text {PHL }}$ | open |
| $\mathrm{t}_{\text {PLZ }} / \mathrm{t}_{\mathrm{PZL}}$ | $2 \times \mathrm{V}_{\mathrm{CC}}$ |
| $\mathrm{t}_{\mathrm{PHZ}} / \mathrm{t}_{\mathrm{PZH}}$ | GND |


| $\mathbf{V}_{\mathbf{C c}}$ | $\mathbf{V}_{\mathbf{I}}$ |
| :--- | :--- |
| $<2.7 \mathrm{~V}$ | $\mathrm{~V}_{\mathrm{CC}}$ |
| 2.7 to 3.6 V | 2.7 V |

Definitions for test circuit.
$\mathrm{C}_{\mathrm{L}}=$ load capacitance including jig and probe capacitance (See Chapter "AC characteristics").
$R_{L}=$ load resistance.
$\mathrm{R}_{\mathrm{T}}=$ termination resistance should be equal to the output impedance $\mathrm{Z}_{\mathrm{o}}$ of the pulse generator.

Fig. 10 Load circuitry for switching times.

# 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state 

## PACKAGE OUTLINE

TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm
SOT364-1


DIMENSIONS (mm are the original dimensions).

| UNIT | $\mathbf{A}$ <br> max. | $\mathbf{A}_{\mathbf{1}}$ | $\mathbf{A}_{\mathbf{2}}$ | $\mathbf{A}_{\mathbf{3}}$ | $\mathbf{b}_{\mathbf{p}}$ | $\mathbf{c}$ | $\mathbf{D}^{(\mathbf{1})}$ | $\mathbf{E}^{(\mathbf{2})}$ | $\mathbf{e}$ | $\mathbf{H}_{\mathbf{E}}$ | $\mathbf{L}$ | $\mathbf{L}_{\mathbf{p}}$ | $\mathbf{Q}$ | $\mathbf{v}$ | $\mathbf{w}$ | $\mathbf{y}$ | $\mathbf{Z}$ | $\boldsymbol{\theta}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 1.2 | 0.15 | 1.05 | 0.25 | 0.28 | 0.2 | 14.1 | 6.2 | 0.5 | 8.3 | 1.0 | 0.8 | 0.50 | 0.25 | 0.08 | 0.1 | 0.5 | $8^{\circ}$ |
|  | 0.05 | 0.85 | 0.25 | 0.17 | 0.1 | 13.9 | 6.0 | 0.1 | 7.9 |  | 0.4 | 0.35 | 0.1 | $0^{\circ}$ |  |  |  |  |

## Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

| OUTLINE <br> VERSION | REFERENCES |  |  |  | EUROPEAN <br> PROJECTION | ISSUE DATE |  |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | IEC | JEDEC | EIAJ |  |  |  |  |
| SOT364-1 |  | MO-153EE |  |  |  | $\square$ | $-93-02-03$ |
| $95-02-10$ |  |  |  |  |  |  |  |

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

## 74ALVCH162601

## SOLDERING

## Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our "Data Handbook IC26; Integrated Circuit Packages" (document order number 9398652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering is not always suitable for surface mount ICs, or for printed-circuit boards with high population densities. In these situations reflow soldering is often used.

## Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, infrared/convection heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to $250^{\circ} \mathrm{C}$. The top-surface temperature of the packages should preferable be kept below $230^{\circ} \mathrm{C}$.

## Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.
- For packages with leads on two sides and a pitch (e):
- larger than or equal to 1.27 mm , the footprint longitudinal axis is preferred to be parallel to the transport direction of the printed-circuit board;
- smaller than 1.27 mm , the footprint longitudinal axis must be parallel to the transport direction of the printed-circuit board.
The footprint must incorporate solder thieves at the downstream end.
- For packages with leads on four sides, the footprint must be placed at a $45^{\circ}$ angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at $250^{\circ} \mathrm{C}$.
A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

## Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage ( 24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to $300^{\circ} \mathrm{C}$.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and $320^{\circ} \mathrm{C}$.

## 18-bit universal bus transceiver with $30 \Omega$ termination resistor; 3-state

Suitability of surface mount IC packages for wave and reflow soldering methods

| PACKAGE | SOLDERING METHOD |  |
| :--- | :--- | :--- |
|  | WAVE | REFLOW ${ }^{(1)}$ |
| BGA, SQFP | not suitable | suitable |
| HLQFP, HSQFP, HSOP, HTSSOP, SMS | not suitable |  |
| PLCC $^{(2)}$, SO, SOJ | suitable | suitable |
| LQFP, QFP, TQFP | not recommended |  |
| SSOP, (4) | suitable |  |

## Notes

1. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the "Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods".
2. These packages are not suitable for wave soldering as a solder joint between the printed-circuit board and heatsink (at bottom version) can not be achieved, and as solder may stick to the heatsink (on top version).
3. If wave soldering is considered, then the package must be placed at a $45^{\circ}$ angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.
4. Wave soldering is only suitable for LQFP, TQFP and QFP packages with a pitch (e) equal to or larger than 0.8 mm ; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm .
5. Wave soldering is only suitable for SSOP and TSSOP packages with a pitch (e) equal to or larger than 0.65 mm ; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm .

## DEFINITIONS

| Data sheet status |  |
| :--- | :--- |
| Objective specification | This data sheet contains target or goal specifications for product development. |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification | This data sheet contains final product specifications. |
| Limiting values | Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or <br> more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation <br> of the device at these or at any other conditions above those given in the Characteristics sections of the specification <br> is not implied. Exposure to limiting values for extended periods may affect device reliability. |
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## NOTES

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## NOTES

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